Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/749,293	LIN ET AL.	
Examiner	Art Unit	
Nauven Nao	2616	

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·	SEARCHED				
. Class	Subclass	Date	Examiner		
370	395.4	12/7/2007	NHN		
370	310	12/7/2007	NHN		
370	310.2	12/7/2007	NHN		
· 370	. 314	12/7/2007	NHN		
370	328	12/7/2007	NHN		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
Consulted SPE Firmin Backer	12/7/2007	NHN
Text Search East see attached	12/7/2007	NHN